SOOS005 D3012, JULY 1986

- Compatible with TTL Inputs
- High Current Transfer Ratio . . . 800% Typ at I<sub>F</sub> = 0.5 mA
- High-Speed Switching . . . 100 kbit/s Typ
- High Common-Mode Transient Immunity . . . 500 V/μs Τγρ
- High-Voltage Electrical Insulation . . . 3000 V DC Min
- High Output Current Rating of 60 mA
- UL Recognized . . . File Number 65085

### description

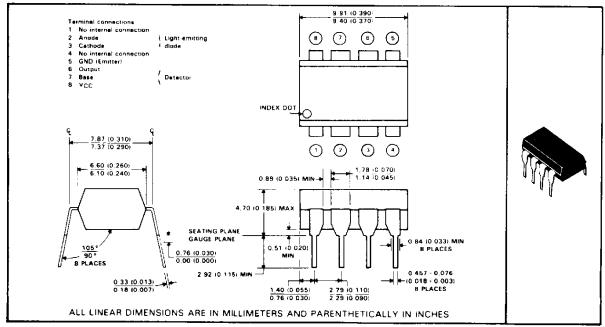
These devices are useful where large common-mode input signals exist, and in applications that require high-voltage isolation between circuits. Applications include line receivers, telephone ring detectors, power line monitors, high-voltage status indicators, and circuits that require isolation between input and output.

The 6N138 and 6N139 high-gain optocouplers each consists of a GaAsP light-emitting diode and an integrated high-gain photon detector composed of a photodiode and a split-Darlington output stage. The VCC and output terminals may be tied together to achieve conventional photodarlington operation. A separate base access terminal allows gain-bandwidth adjustments.

The 6N138 is designed for use primarily in TTL applications. An LED input current of 1.6 milliamperes and a current-transfer ratio of 300% from 0°C to 70°C allows operation with one TTL load input and one TTL load output utilizing a 2.2-k $\Omega$  pullup resistor.

The 6N139 is designed for use in CMOS, LSTTL, or other low-power applications. This device has a minimum current-transfer ratio of 400% for only 0.5 milliampere input current over an operating temperature range of 0°C to 70°C.

### \*mechanical data

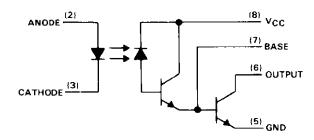


\*JEDEC registered data. This data sheet contains all applicable registered data in effect at the time of publication



# 6N138, 6N139 OPTOCOUPLERS/OPTOISOLATORS

#### schematic



## \*absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

Supply and output voltage range, VCC and VO: 6N138 0.5 V to 7 V
6N139
Reverse input voltage
Emitter-base reverse voltage
Peak input forward current (pulse duration = 1 ms, 50% duty cycle)
Peak transient input forward current (pulse duration ≤ 1 µs, 300 pps) 1 A
Average forward input current at (or below) 50 °C free-air temperature (see Note 1) 20 mA
Output current at (or below) 25 °C free-air temperature (see Note 2) 60 mA
Input power dissipation at (or below) 50 °C free-air temperature (see Note 3)
Output power dissipation at (or below) 25 °C free-air temperature (see Note 4) 100 mW
Storage temperature range
Operating temperature range
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds

- NOTES 1. Denate linearly above 50 °C free-air temperature at a rate of 0.4 mA/ °C. 2. Denate linearly above 25 °C free air temperature at a rate of 0.8 mA/ °C.

  - 3. Denate linearly above 50 °C free air temperature at a rate of 0.7 mW/ °C.
  - 4. Derate linearly above 25 °C free-air temperature at a rate of 1.33 mW: °C.
- \*JEDEC registered data.

## electrical characteristics over operating free-air temperature range of 0 °C to 70 °C (unless otherwise noted)

	OAD AMETED	TEST	ONDITIONS	6N138			6N139			
PARAMETER		TEST	ONDITIONS	MIN	TYPT	MAX	MIN	TYP	MAX	UNIT
*VF	Input forward voltage	lp = 1.6 mA,	TA = 25°C		1.5	1.7		1.5	1.7	V
αVF	Temperature coefficient of forward voltage	IF = 1.6 mA			-1.8			- 1.8		mV/°C
*VBR	Input breakdown voltage	IR = 10 μA,		5			5			V
		V <sub>CC</sub> = 4.5 V, I <sub>OL</sub> = 4.8 mA,	•		0.1	0.4				
Vol	Low-level output voltage	$V_{CC} = 4.5 \text{ V},$ $I_{OL} = 6.4 \text{ mA},$	I <sub>B</sub> = 0					0.1	0.4	V
VOL		$V_{CC} = 4.5 \text{ V},$ $I_{OL} = 15 \text{ mA},$	ig = 0					0.1	0.4	
		$V_{CC} = 4.5 \text{ V},$ $I_{OL} = 24 \text{ mA},$	I <sub>B</sub> = 0					0.2	0.4	
*Іон	High-level output current	$V_{CC} = 7 V$ , $I_F = 0$ ,	$V_O = 7 V$ , $I_B = 0$		0.1	250			<u>.</u>	μΑ
.01		$V_{CC} = 18 V$ , $I_F = 0$ ,	IB = 0					0.05	100	1 '
*ICCH	Supply current, high-level output	V <sub>CC</sub> = 5 V, I <sub>F</sub> = 0,	le = 0		10			10		nA
<sup>I</sup> CCL	Supply current, low-level output	V <sub>CC</sub> = 5 V, I <sub>F</sub> = 1.6 mA,	IB = 0		0.2			0.2		mA
*CTR	Current transfer ratio	V <sub>CC</sub> ≈ 4.5 V, I <sub>F</sub> = 0.5 mA, See Note 5	_		<u></u>		400%	1650%		
		V <sub>CC</sub> = 4.5 V, I <sub>F</sub> = 1.6 mA, See Note 5	_	300%	1300%		500%	1400%		
rio .	Input-output resistance	V <sub>IO</sub> = 500 V	See Note 6		1012			1012	·	Ω
•110	Input-output insulation leakage current	V <sub>IO</sub> = 3000 V, T <sub>A</sub> = 25°C, See Note 6				1			1	μΑ
Ci	Input capacitance	V <sub>F</sub> = 0.	f = 1 MHz		60	·		60		pF
Cio	Input-output capacitance	f = 1 MHz,	See Note 6	1	0.6			0.6		pF

<sup>\*</sup>JEDEC registered data  $^{\dagger}$ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25 °C, unless otherwise noted. NOTES. 5. Current transfer ratio is defined as the ratio of output collector current I<sub>O</sub> to the forward LED input current I<sub>F</sub> times 100%.

<sup>6.</sup> These parameters are measured between pins 2 and 3 shorted together and pins 5, 6, 7, and 8 shorted together.

# 6N138, 6N139 OPTOCOUPLERS/OPTOISOLATORS

# \*switching characteristics at VCC = 5 V, TA = 25 °C

PARAMETER		7507.0	MOITIONO	6N138		6N139				
		IEST CO	ONDITIONS	MIN TYP MAX			MIN	TYP	MAX	UNIT
4.	Propagation delay time, high-to-low level output	lp = 1.6 mA,	$R_L = 2.2 k\Omega$ ,		2	10			·	
		See Figure 1			2	10	İ			
		lf = 0.5 mA,	$R_L = 4.7 \text{ k}\Omega$ ,					4	25	_
*tPHL		See Figure 1						4	23	μ5
		IF = 12 mA,	R <sub>L</sub> = 270 Ω,					0.3	1	
		See Figure 1						0.3	'	
		lp = 1.6 mA,	$R_L = 2.2 \text{ k}\Omega$		4	35				
		See Figure 1		4 3		35				
44	Propagation delay time,	$l_F = 0.5 \text{ mA},$	$R_L = 4.7 k\Omega$					10	60	
*tPLH	low-to-high-level output	See Figure 1		ļ				10	00	μS
		lç = 12 mA,	$R_L = 270 \Omega$ ,					3.5	7	
		See Figure 1						4.5	. ,	
dVa.	Common-mode input	$V_{CM} = 10 \text{ Vp-p}$	le = 0,							
dVCM (H)	Transient immunity,	$R_L = 2.2 k\Omega$ .	See Notes 7 and 8.		500			500		V/μ5
	high-level output	See Figure 2								
dVCM dt (L)	Common-mode input	.,			- 500		500			
	transient immunity,	VCM = Vp-p,	-	- 5				500		V/µs
	low-level output	See Figure 2,	See Notes 7 and 8						ا ا	

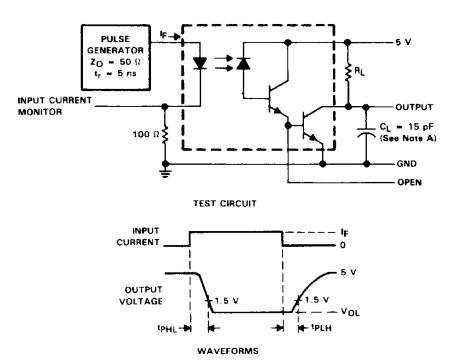
<sup>\*</sup>JEDEC registered data

NOTES: 7. Common-mode transient immunity, high-level output, is the maximum rate of rise of the common-mode input voltage that does not cause the output voltage to drop below 2 V. Common mode input transient immunity, low level output, is the maximum rate of fall of the common mode input voltage that does not cause the output voltage to rise above 0 8 V.

8. In applications where dV/d1 may exceed 50,000 V/µs (such as static discharge) a series resistor, R<sub>CC</sub>, should be included to protect the detector IC from destructively high surge currents. The recommended value is:

$$R_{CC} \approx \frac{1}{0.15 \, (\text{p (mA)})} \, k\Omega$$

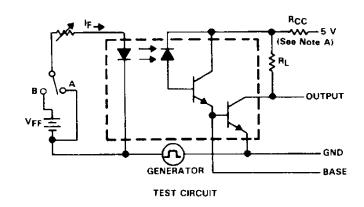
## PARAMETER MEASUREMENT INFORMATION

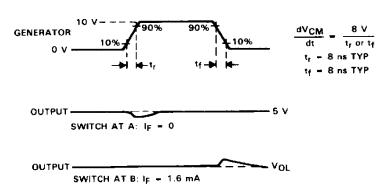


NOTE A.  $C_{\rm L}$  includes probe and stray capacitances.

FIGURE 1. SWITCHING TEST CIRCUIT AND WAVEFORMS

# PARAMETER MEASUREMENT INFORMATION





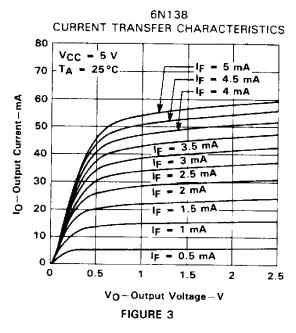
### VOLTAGE WAVEFORMS

NOTE A: In applications where dV/dt may exceed 50,000  $V_{\ell\mu}s$  (such as static discharge) a series resistor, R<sub>CC</sub>, should be included to protect the detector IC from destructively high surge currents. The recommended value is:

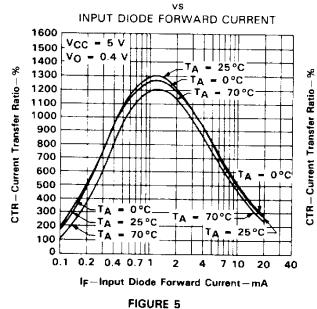
$$R_{CC} = -\frac{1}{0.15 \, I_F \, (mA)} \, k \Omega$$

FIGURE 2. TRANSIENT IMMUNITY TEST CIRCUIT AND WAVEFORMS

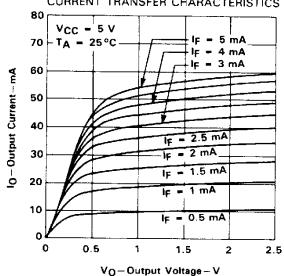
### TYPICAL CHARACTERISTICS



6N138 CURRENT TRANSFER RATIO

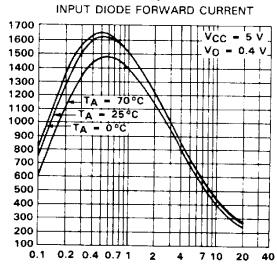


6N139 CURRENT TRANSFER CHARACTERISTICS



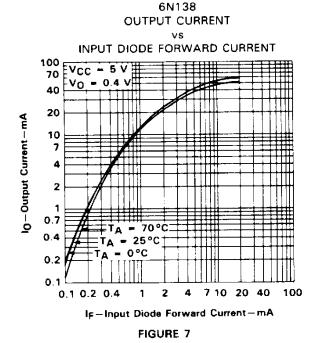
6N139 CURRENT TRANSFER RATIO vs

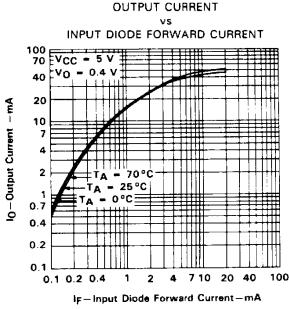
FIGURE 4



IF—Input Diode Forward Current—mA FIGURE 6

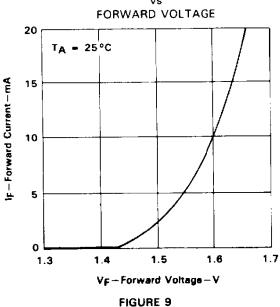
### TYPICAL CHARACTERISTICS





6N139

INPUT DIODE FORWARD CURRENT



6N138 PROPAGATION DELAY TIMES VS

FIGURE 8

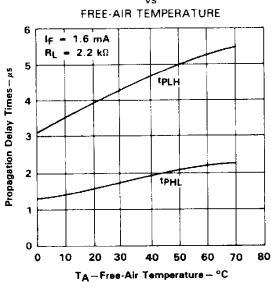
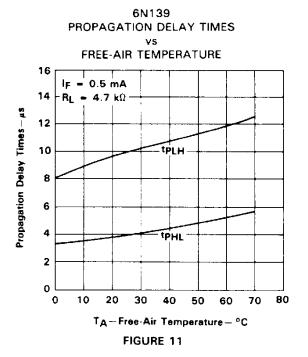
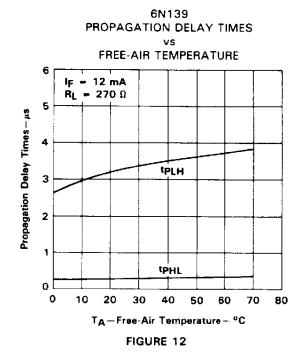


FIGURE 10

## TYPICAL CHARACTERISTICS





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## PACKAGE OPTION ADDENDUM

8-Apr-2005

### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp (3)
6N138	OBSOLETE	PDIP	N	8	TBD	Call TI	Call TI
6N139	OBSOLETE	PDIP	N	8	TBD	Call TI	Call TI

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in

a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check <a href="http://www.ti.com/productcontent">http://www.ti.com/productcontent</a> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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